

## **Supplementary information**

### **Nitrogen doped In<sub>2</sub>O<sub>3</sub>-ZnO nanocomposite mesoporous thin film based highly sensitive and selective ethanol sensor**

*P. K. Shihabudeen and Ayan Roy Chaudhuri\**

*Materials Science Centre, Indian Institute of Technology Kharagpur, 721302 Kharagpur,  
West Bengal, India*

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\* Corresponding author: Tel: +91-3222-283978

Electronic mail: [ayan@matsc.iitkgp.ac.in](mailto:ayan@matsc.iitkgp.ac.in) (Ayan Roy Chaudhuri)

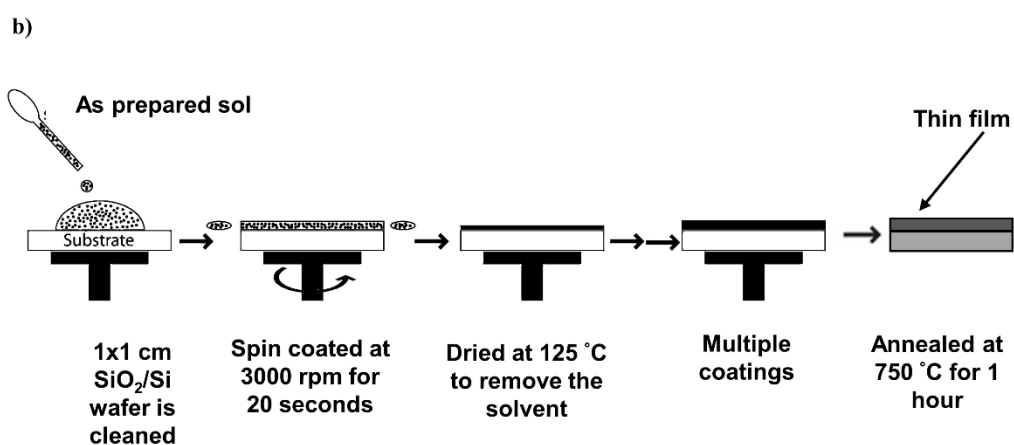
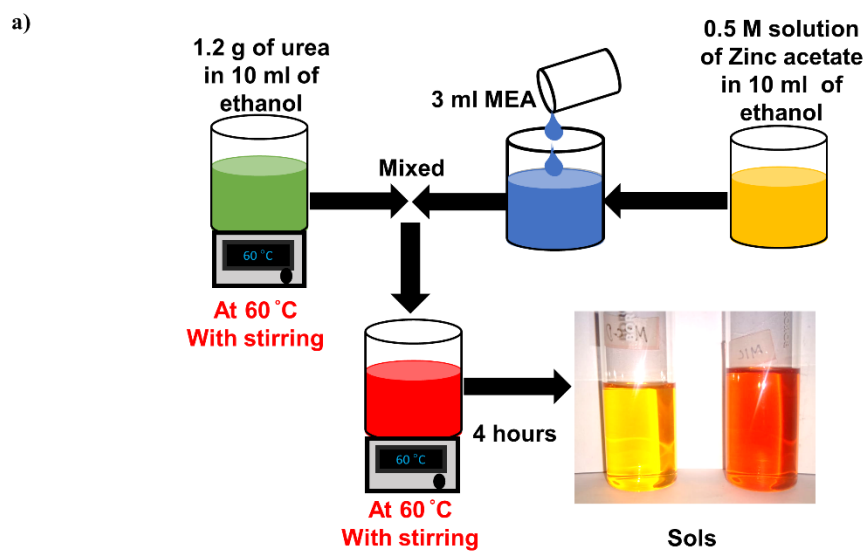


Figure S1. a) synthesis of sol and b) synthesis of the composite thin film by spin coating technique.

Table S1. Details of chemicals used for synthesis of composites

Sl.no	Sample	Zinc acetate (g)	Indium acetate (g)
1	IZON-25	0.822	0.365
2	IZON-50	0.549	0.723
3	IZON-75	0.275	1.094
4	IZO-50	0.822	0.365

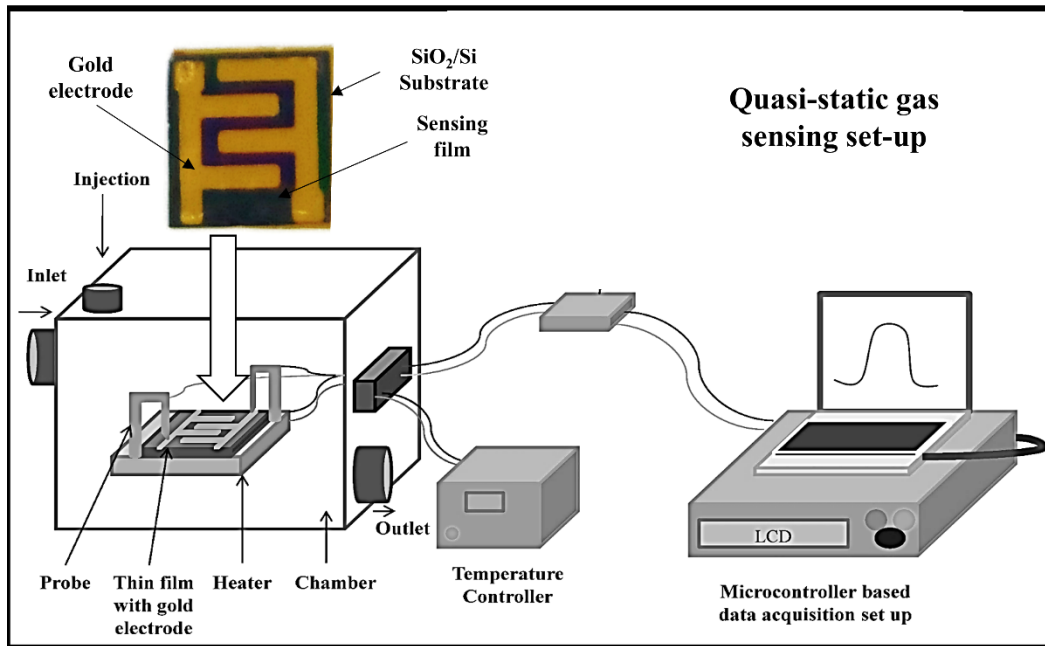


Figure S2. photograph of the fabricated device and the schematic of quasi-static gas sensing set-up.

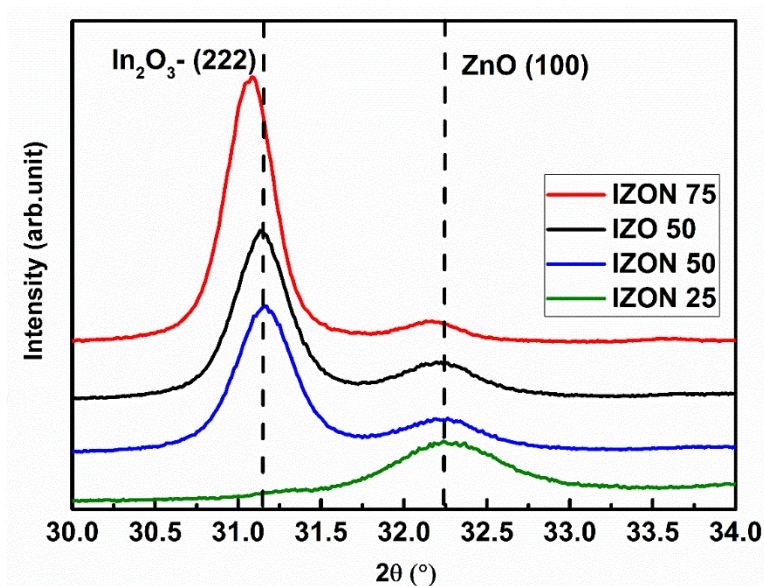


Figure S3. Shift in two major XRD peaks of composites thin films

The crystallite size of the In<sub>2</sub>O<sub>3</sub> and ZnO has been calculated for the composite thin films

using the Scherrer equation,  $D = \frac{K\lambda}{\beta \cos(\theta)}$ , Where D is the crystallite size of the thin films,  $\lambda$  is the X-ray wavelength (1.54 Å),  $\beta$  is the FWHM in radians, K is constant with a value of 0.94, and  $\theta$  is the peak position in radians. Further the micro strain ( $\epsilon$ ) along the In<sub>2</sub>O<sub>3</sub> (222)

and ZnO (100) plane of the thin films is calculated using the equation,  $\epsilon = \frac{\beta}{4 \tan \theta}$ .

Table S2. Estimated parameters from XRD analysis

Sample	Crystallite size, D (nm) ±0.5 nm		Cell parameters (Å) ±0.02 Å		Strain ( $\epsilon$ ) x 10 <sup>-3</sup>	
	In <sub>2</sub> O <sub>3</sub>	ZnO	In <sub>2</sub> O <sub>3</sub> , a	ZnO, a & c	In <sub>2</sub> O <sub>3</sub> (222)	ZnO (100)
IZON 25	26.18	13.42	10.31	3.24 & 5.22	3.17	13.3
IZON 50	19.04	10.92	10.22	3.24 & 5.20	4.57	9.49
IZO 50	20.95	14.21	10.22	3.24 & 5.20	4.14	7.41
IZON 75	23.94	31.51	10.42	3.23 & 5.21	3.33	3.32

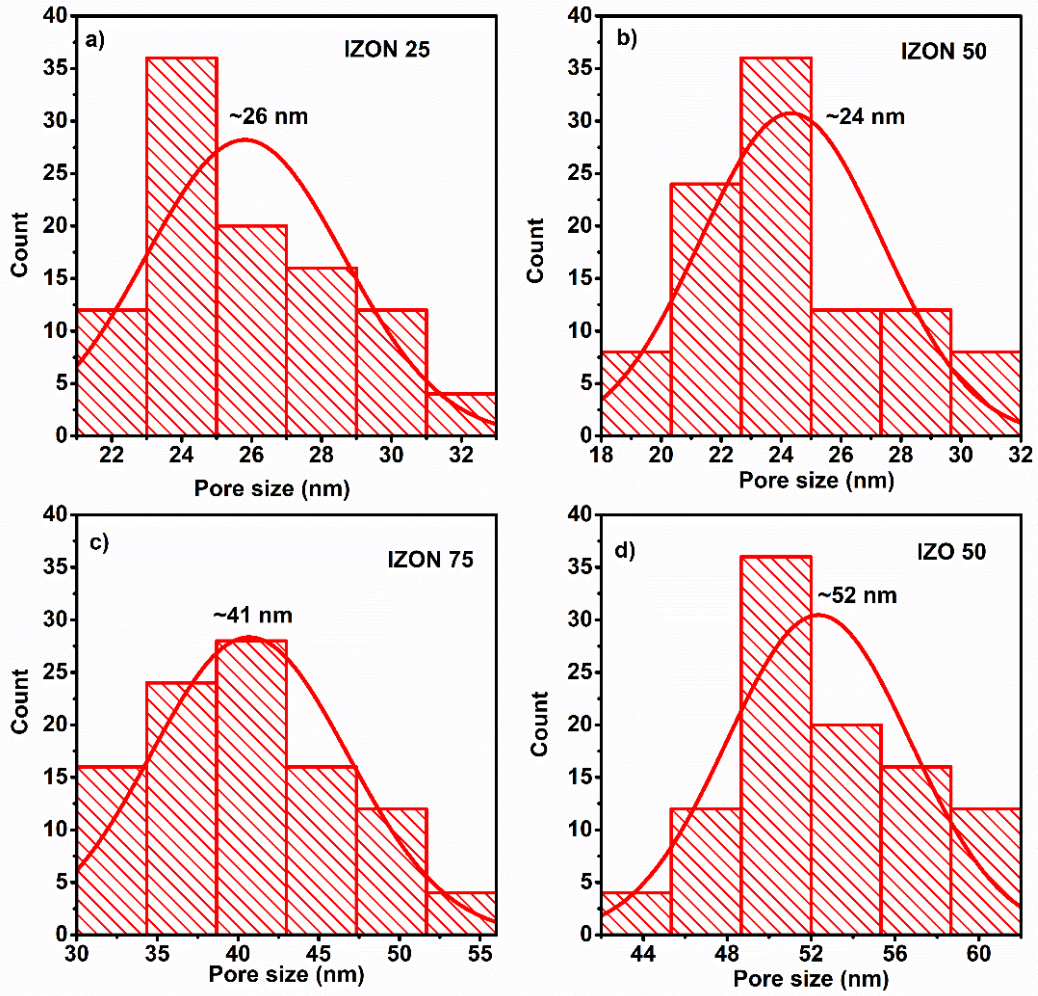


Figure S4. Surface pore size distribution of a) IZON 25, b) IZON 50, IZON 75 and IZO 50 composite thin films.

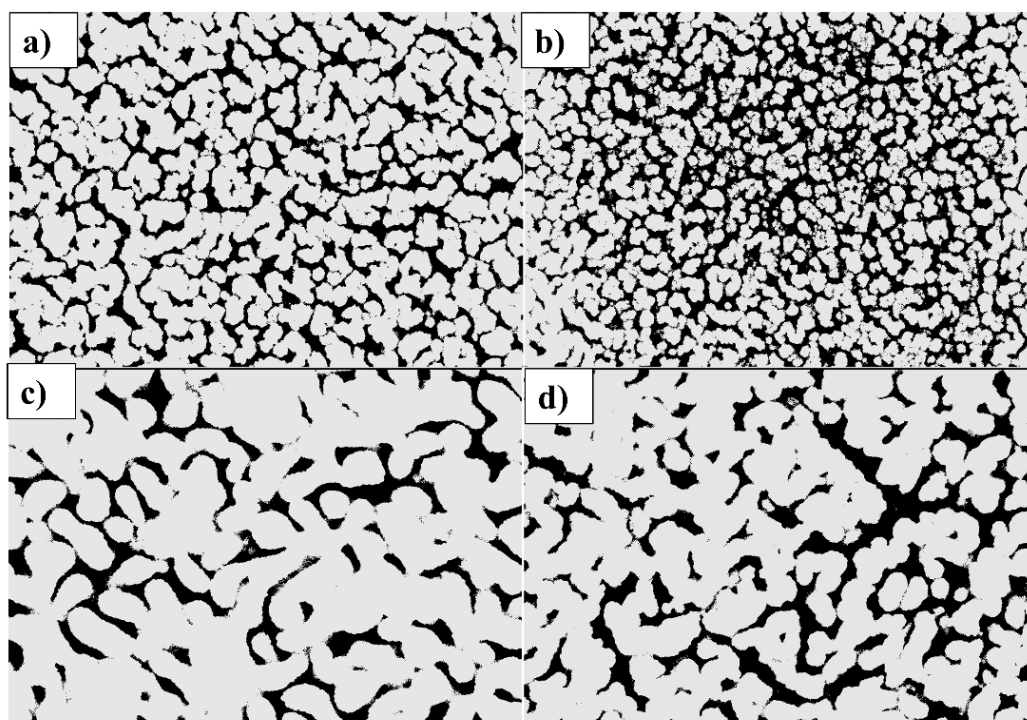


Figure S5 Processed scanning electron microscopy images of a) IZON 25, b) IZON 50, c) IZON 75 and d) IZO 50 composite thin films

Table S3. Composition of composite thin films

Film/Atom (at%)	N	O	In	Zn
IZON-25	0.60	58.11	11.38	29.91
IZON-50	0.60	61.37	19.21	18.82
IZON-75	0.60	57.71	31.46	10.22
IZO-50	0	61.61	19.52	18.87

Table S4. Sensing response, response and recovery times of various composite thin films

Film	Response at 200 °C (%)	Response time (s)	Recovery time (s)
IZON-25	~80	~5	~300
IZON-50	~94	~2	~300
IZON-75	~50	~30	~300
IZO-50	~77	~9	~250

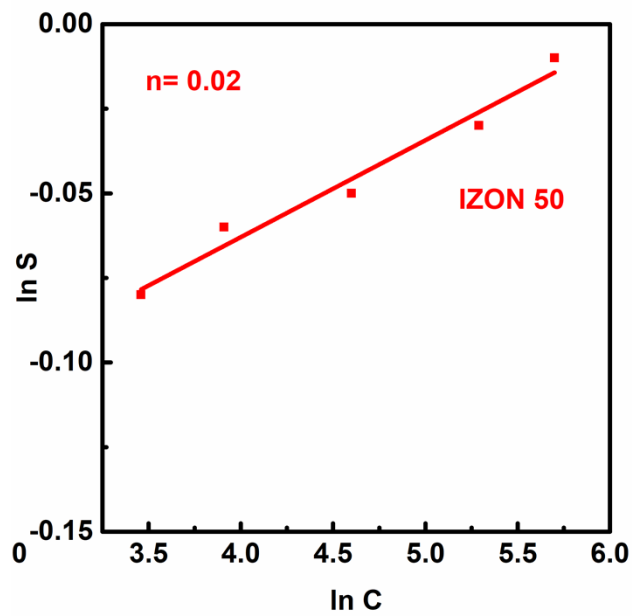


Figure S6. Sensitivity plot of IZON 50 thin film.

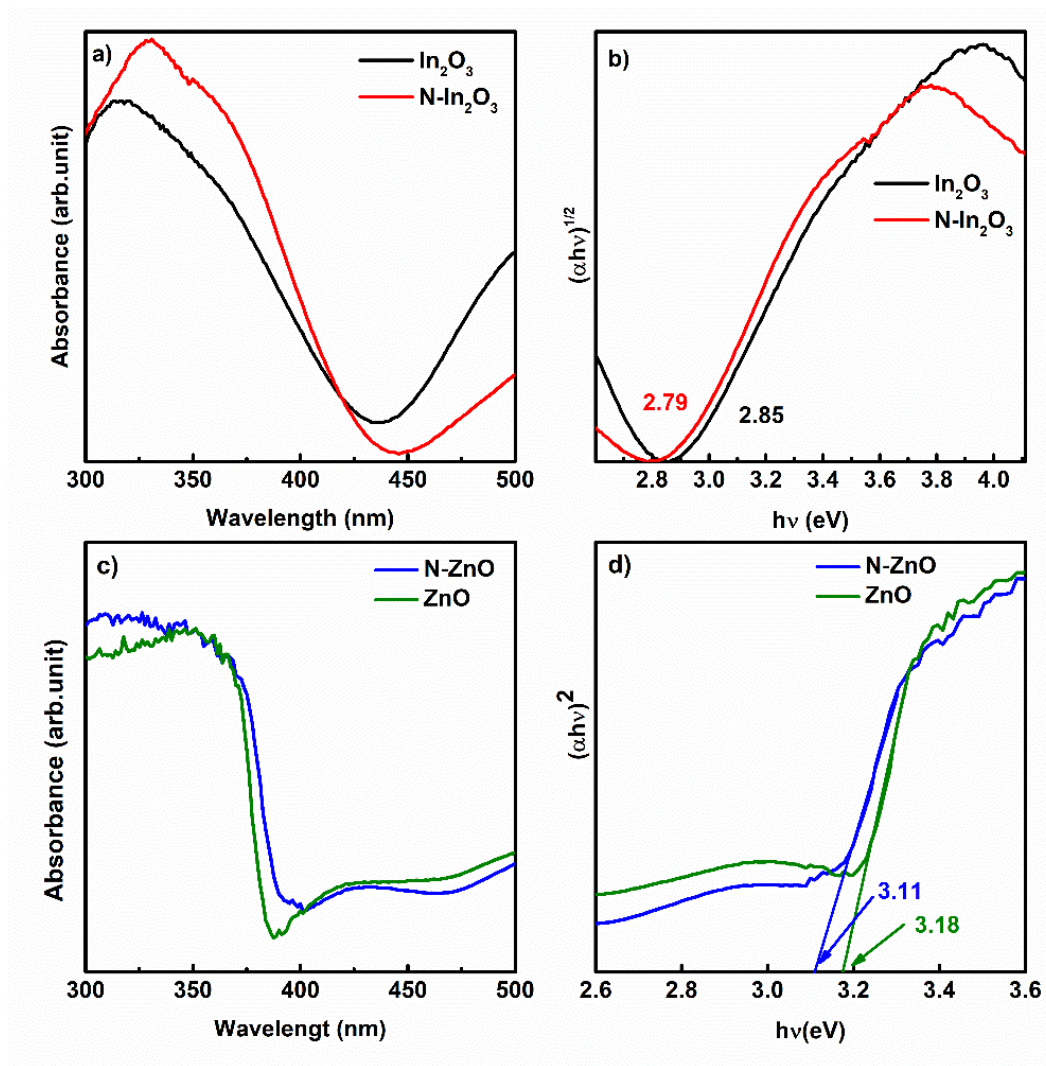


Figure S7 a&c) DRS and b&d) Tauc plot of individual metal oxide thin films.

Table S5. Sensing parameters of various thin films

Film	Temperature (°C)	Response (%)
IZO-50	200	~74
IZON-50	200	~94
N-ZnO	225	~86
N-In <sub>2</sub> O <sub>3</sub>	250	~82



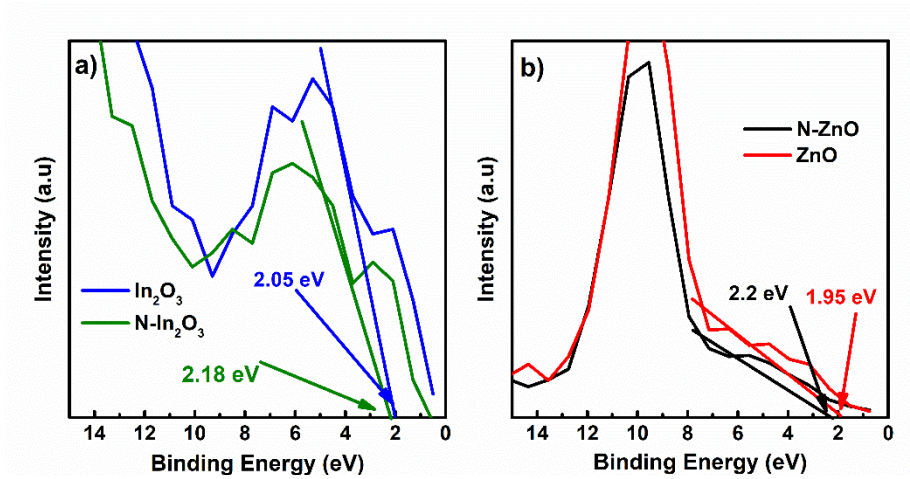


Figure S8. Valence band edge diagrams of a)  $\text{In}_2\text{O}_3$  &  $\text{N-In}_2\text{O}_3$  and b)  $\text{ZnO}$  &  $\text{N-ZnO}$